Towards increased efficiency in solar energy harvesting via intermediate states







Renee Sher



Yu-Ting Lin



Kasey Philips



Ben Franta



and also

Marc Winkler Eric Diebold Haifei Albert Zhang Dr. Brian Tull Dr. Jim Carey (SiOnyx) Prof. Tsing-Hua Her (UNC Charlotte) Dr. Shrenik Deliwala Dr. Richard Finlay Dr. Michael Sheehy Dr. Claudia Wu Dr. Rebecca Younkin Prof. Catherine Crouch (Swarthmore) Prof. Mengyan Shen (Lowell U) Prof. Li Zhao (Fudan U)

> Dr. Elizabeth Landis Dr. John Chervinsky

Prof. Alan Aspuru-Guzik Prof. Michael Aziz Prof. Michael Brenner Prof. Cynthia Friend Prof. Howard Stone Prof. Tonio Buonassisi (MIT) Prof. Silvija Gradecak (MIT) Prof. Jeff Grossman (MIT) Dr. Bonna Newman (MIT) Joe Sullivan (MIT) Matthew Smith (MIT)

Prof. Augustinus Asenbaum (Vienna)

Dr. François Génin (LLNL) Mark Wall (LLNL)

Dr. Richard Farrell (RMD) Dr. Arieh Karger (RMD) Dr. Richard Meyers (RMD)

Dr. Pat Maloney (NVSED)

Dr. Jeffrey Warrander (ARDEC)

...and the people at SiOnyx



irradiate with 100-fs 10 kJ/m² pulses







absorptance
$$(1 - R_{int} - T_{int})$$



absorptance
$$(1 - R_{int} - T_{int})$$





absorptance
$$(1 - R_{int} - T_{int})$$



absorptance
$$(1 - R_{int} - T_{int})$$



absorptance
$$(1 - R_{int} - T_{int})$$



laser treatment causes:

- surface structuring
- inclusion of dopants

substrate/dopant combinations

dopants:

																	VIII
$\left \cdot \right $													IV	V	VI	VII	He
Li	Be											В	С	Ν	0	F	Ne
Na	Mg											AI	Si	Ρ	S	CI	Ar
Κ	Са	Sc	Ti	V	Cr	Mn	Fe	Со	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Мо	Тс	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Те		Xe

substrates:

Si

substrate/dopant combinations

dopants:

																	VIII
Η													IV	V	VI	VII	He
Li	Be											В	С	Ν	0	F	Ne
Na	Mg											AI	Si	Ρ	S	CI	Ar
Κ	Са	Sc	Ti	\vee	Cr	Mn	Fe	Со	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Мо	Тс	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Те		Xe

substrates:

Si

substrate/dopant combinations



substrates:

Si Ge ZnO InP GaAs Ti Ag Al Cu Pd Rh Ta Pt TiO₂



gap determines optical and electronic properties



shallow-level dopants control electronic properties



shallow-level dopants control electronic properties



deep-level dopants typically avoided



femtosecond laser-doping gives rise to intermediate band





















intermediate band formation in chalcogen-hyperdoped Si



substrates:

Si













cross-sectional Transmission Electron Microscopy





M. Wall, F. Génin (LLNL)

1 intermediate band

1 µm








- 300-nm disordered surface layer
- undisturbed crystalline core

• surface layer: polycrystalline Si with 1.6% sulfur

1 µm

















Nature Materials 1, 217 (2002)



Nature Materials 1, 217 (2002)



Nature Materials 1, 217 (2002)

































at high concentration states broaden into band



10⁻⁶ sulfur doping



laser-doped S:Si



laser-doped S:Si



laser-doped S:Si

















impurity (donor) band centered at 310 meV








Hall measurements



Things to keep in mind

- \bullet IR absorption rolls off around 8 μm
- evidence of intermediate band formation
- intermediate band due to substitutional S donors
- intermediate band 0–300 meV below CB









should have shallow junction below surface







excellent rectification (after annealing)





SiOnyx

http://www.sionyx.com



Potential benefits for photovoltaics

surface structure

- absorption in submicrometer layer
- extended IR absorption
- intermediate band









photon with gap energy





photon creates electron-hole pair...





...whose energy can be extracted





photons with energy smaller than gap...







...do not get absorbed





photons with energy larger than the gap...





... create electron-hole pairs with excess energy...





...which is lost rapidly





black silicon has an intermediate band





absorbs same photons as ordinary silicon...





... but extends absorption to longer wavelengths





could theoretically get efficiencies over 50%





Things to keep in mind

- can turn absorption into carrier generation (photodetectors)
- very high optical density
- intermediate band photovoltaic devices?















































































solar radiation spectrum







solar radiation spectrum



1 intermediate band

2 Si devices



solar radiation spectrum



1 intermediate band

2 Si devices


increase efficiency by:

1/24

- increasing surface area
- shifting band edge





TiO₂ density of states



Asahi et al., Science (2001)







Asahi et al., Science (2001)







Asahi et al., Science (2001)







Asahi et al., Science (2001)







Asahi et al., Science (2001)





structuring TiO₂ in N₂ doesn't work



























50 pulses @ 2.5 kJ/m²

































oxygen is incorporated!







oxygen is incorporated!







nitrogen peak appears...







... but nitrogen not chemically incorporated







... but nitrogen not chemically incorporated







with both nitrogen and oxygen...







... just 1% of oxygen prevents nitrogen incorporation...







... although oxygen is incorporated







can get N₂ or O₂ incorporated, but not both







can get N₂ or O₂ incorporated, but not both

textured TiO₂/Ti: high biocompatibility







TiO₂ density of states: other dopants



Si devices

2

3 X:TiO₂

how about incorporating chromium with oxygen?







evaporate 10 – 70 nm chromium on titanium...







...place in oxygen atmosphere...







... irradiate with laser...







...and raster scan to structure













both chromium and oxygen incorporated!













Can produce:

microstructured TiO₂ (high biocompatibility)

• can dope TiO, with Cr, but not N







Summary

- new doping process
- new class of material
- new types of devices/








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for more information and a copy of this presentation:

http://mazur.harvard.edu























ероху	
laser affected region	
substrate	
100 nm	

ероху		
laser affected region		
substrate		
100 nm		





secondary ion mass spectrometry



secondary ion mass spectrometry



device layer buried oxide

silicon substrate



laser doped region buried oxide

silicon substrate



















titanium/chromium in oxygen







two processes: melting and ablation



different thresholds:

melting: 1.5 kJ/m²

ablation: 3.1 kJ/m²



solar spectrum





solar spectrum





crystalline silicon: transparent to 23% of solar radiation





amorphous silicon: transparent to 53% of solar radiation





black silicon: potential to recover transmitted energy











What is different about this process?







Compare femtosecond laser doping to:

- inclusion during growth
- thermal diffusion
- ion implantation





